**RUA PACKAGE** 

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# 16-BIT TO 8-BIT MULTIPLEXER/DEMULTIPLEXER GIGABIT ETHERNET LAN SWITCH WITH POWER DOWN MODE

Check for Samples: TS3L501E

#### **FEATURES**

- Integrated Power Down Mode
- Wide Bandwidth (BW = 600 MHz Typ)
- Low Crosstalk (X<sub>TALK</sub> = -37 dB Typ
   250 MHz)
- Low Bit-to-Bit Skew (t<sub>sk(o)</sub> = 100 ps Max)
- Low and Flat ON-State Resistance (r<sub>on</sub> = 4 Ω Typ, r<sub>on(flat)</sub> = 0.5 Ω Typ)
- Low Input/Output Capacitance (C<sub>ON</sub> = 9 pF Typ)
- Rail-to-Rail Switching on Data I/O Ports (0 to 3.6 V)
- V<sub>CC</sub> Operating Range From 3 V to 3.6 V
- Support Power Down Mode
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance (A, B, C, LED pins)
  - ± 4-kV IEC61000-4-2, Contact Discharge
  - 6-kV Human Body Model Per JESD22-A114E (Switch I/O pins to GND)
- ESD Performance (All pins)
  - 2-kV Human Body Model Per JESD22-A114E

#### **APPLICATIONS**

- 10/100/1000 Base-T Signal Switching
- Differential (LVDS, LVPECL) Signal Switching
- Audio/Video Switching
- Hub and Router Signal Switching

#### (TOP VIEW) $\mathbf{B}_2$ $V_{DD}$ $B_0$ (38 1) $A_0$ (37 B<sub>1</sub> 3) (36 $C_0$ $V_{DD}$ (35 $C_1$ 4 PD (34 $B_2$ $A_2$ (33 $B_3$ 7) (32 $C_2$ $V_{DD}$ 8 (31 $C_3$ Exposed Center Pad (30 $V_{DD}$ 9) (GND) $A_5$ 10) 29 В $A_6$ 11) (28 $B_5$ $A_7$ 12) (27 $C_{\Delta}$ SEL (26 $C_5$ 14) $V_{DD}$ (25 $B_6$ LED\_A<sub>0</sub> 24 $B_7$ LED\_A<sub>1</sub> (23 16) $C_6$ LED\_B<sub>0</sub> 17) (22 $C_7$ ပိ $^{\circ}$ æ.

The exposed center pad must be connected to GND.

#### **DESCRIPTION/ORDERING INFORMATION**

The TS3L501E is a 16-bit to 8-bit multiplexer/demultiplexer LAN switch with a single select (SEL) input and Power down Mode input. The device provides additional I/Os for switching status indicating LED signals and includes high ESD protection. SEL input controls the data path of the multiplexer/demultiplexer. Power down input can put the device into the standby mode for minimizing current consumption per mode selection.

The device provides a low and flat ON-state resistance (Ron) and an excellent ON-state resistance match. Low input/output capacitance, high bandwidth, low skew, and low crosstalk among channels make this device suitable for various LAN applications, such as 10/100/1000 Base-T. This device can be used to replace mechanical relays in LAN applications. It also can be used to route signals from a 10/100 Base-T Ethernet transceiver to the RJ-45 LAN connectors in laptops or in docking stations.

It is characterized for operation over the free-air temperature range of -40°C to 85°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

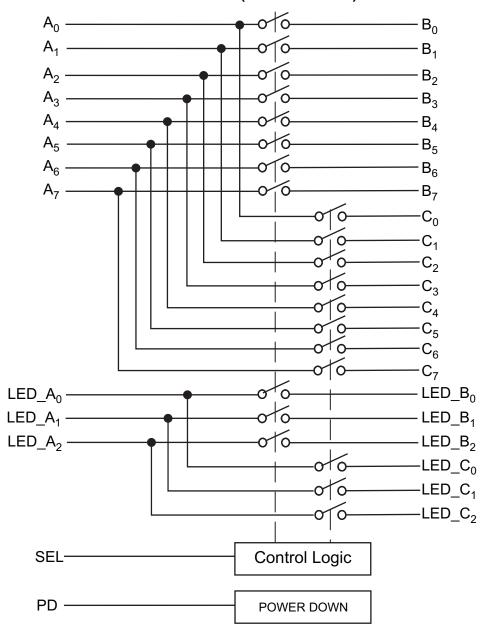


#### **Table 1. ORDERING INFORMATION**

| T <sub>A</sub> | PACKAGE <sup>(1)</sup> .(2) |               | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
|----------------|-----------------------------|---------------|-----------------------|------------------|
| -40°C to 85°C  | TQFN – RUA                  | Tape and reel | TS3L501ERUAR          | TK501E           |

- Package drawings, thermal data, and symbolization are available at <a href="https://www.ti.com/packaging">www.ti.com/packaging</a>.
  For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

#### **LOGIC DIAGRAM (POSITIVE LOGIC)**





#### **FUNCTION TABLE**

| PD | SEL | FUNCTION                                  |
|----|-----|---|
| L  | L   | $A_n$ to $B_n$ , LED_ $A_n$ to LED_ $B_n$ |
| L  | Н   | $A_n$ to $C_n$ , LED_ $A_n$ to LED_ $C_n$ |
| Н  | X   | Hi-Z                                      |

#### **PIN DESCRIPTION**

| NAME  | DESCRIPTION                      |
|---|----------------------------------|
| A <sub>n</sub>  | Port A DeMux I/O                 |
| B <sub>n</sub> , C <sub>n</sub>                                 | Port B, C Mux I/O                |
| LED_A <sub>n</sub> , LED_B <sub>n</sub> ,<br>LED_C <sub>n</sub> | LED Mux I/O                      |
| SEL   | Select Input                     |
| PD  | Power Down<br>Input, Active High |
| GND   | Ground                           |
| $V_{DD}$  | Power                            |

#### ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

|                   | peraung nee-an temperature range (um              | coo otherwise noted) |      |      |      |
|-------------------|---|----------------------|------|------|------|
|                   |   |                      | MIN  | MAX  | UNIT |
| $V_{DD}$          | Supply voltage range                              |                      | -0.5 | 4.6  | V    |
| V <sub>IN</sub>   | Control input voltage range (2) (3)               |                      | -0.5 | 7    | V    |
| V <sub>I/O</sub>  | Switch I/O voltage range <sup>(2) (3) (4)</sup>   |                      | -0.5 | 7    | V    |
| I <sub>IK</sub>   | Control input clamp current                       | V <sub>IN</sub> < 0  |      | -50  | mA   |
| I <sub>I/OK</sub> | I/O port clamp current                            | V <sub>I/O</sub> < 0 |      | -50  | mA   |
| I <sub>I/O</sub>  | ON-state switch current <sup>(5)</sup>            |                      |      | ±128 | mA   |
|                   | Continuous current through V <sub>DD</sub> or GND |                      | ±100 | mA   |      |
| $\theta_{JA}$     | Package thermal impedance (6)                     |                      |      | 51.2 | °C/W |
| T <sub>stg</sub>  | Storage temperature range                         |                      | -65  | 150  | °C   |

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- All voltages are with respect to ground, unless otherwise specified.
- The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- $V_I$  and  $V_O$  are used to denote specific conditions for  $V_{I/O}$ .
- $I_{\rm I}$  and  $I_{\rm O}$  are used to denote specific conditions for  $I_{\rm I/O}$ . The package thermal impedance is calculated in accordance with JESD 51-7.

### RECOMMENDED OPERATING CONDITIONS(1)

|                  |  | MIN | MAX      | UNIT |
|------------------|--|-----|----------|------|
| $V_{DD}$         | Supply voltage                         | 3   | 3.6      | V    |
| $V_{IH}$         | High-level control input voltage (SEL) | 2   | 5.5      | V    |
| $V_{IL}$         | Low-level control input voltage (SEL)  | 0   | 8.0      | V    |
| $V_{IN}$         | Input voltage (SEL)                    | 0   | 5.5      | V    |
| V <sub>I/O</sub> | Input/output voltage                   | 0   | $V_{DD}$ | V    |
| T <sub>A</sub>   | Operating free-air temperature         | -40 | 85       | °C   |

(1) All unused control inputs of the device must be held at V<sub>DD</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

Product Folder Link(s): TS3L501E



#### **ELECTRICAL CHARACTERISTICS**

for 1000 Base-T Ethernet switching over recommended operating free-air temperature range, V<sub>DD</sub> = 3.3 V ± 0.3 V

(unless otherwise noted)

| P                         | ARAMETER    |                        | TEST CONDITIONS <sup>(1)</sup>                                      |                         |            |  |      | MAX  | UNIT |
|---------------------------|-------------|------------------------|---|-------------------------|------------|--|------|------|------|
| $V_{IK}$                  | SEL, PD     | $V_{DD} = 3.6 V,$      | $I_{IN} = -18 \text{ mA}$   |                         |            |  | -0.7 | -1.2 | V    |
| I <sub>IH</sub>           | SEL, PD     | $V_{DD} = 3.6 V,$      | $V_{IN} = V_{DD}$   |                         |            |  |      | ±2   | μΑ   |
| I <sub>IL</sub>           | SEL, PD     | $V_{DD} = 3.6 V,$      | $V_{IN} = GND$  |                         |            |  |      | ±1   | μΑ   |
| I <sub>OFF</sub>          | SEL, PD     | $V_{DD} = 0 V$ ,       | $V_{IN} = 0 \text{ to } 3.6 \text{ V}$                              |                         |            |  |      | ±1   | μΑ   |
| I <sub>CC</sub>           |             | $V_{DD} = 3.6 V,$      | $I_{I/O}=0$ ,   | Switch ON or Of         | -F         |  | 250  | 600  | μА   |
| I <sub>CC_PD</sub>        |             | $V_{DD} = 3.6 V,$      | $V_{IN} = 3.6 V,$   | PD = High               |            |  | 1    |      |      |
| C <sub>IN</sub>           | SEL, PD     | f = 1 MHz,             | V <sub>IN</sub> = 0   |                         |            |  | 2.6  | 3.0  | pF   |
| C <sub>OFF</sub>          | B or C port | $V_I = 0$ ,            | f = 1 MHz,  | Outputs open,           | Switch OFF |  | 3    | 4    | pF   |
| C <sub>ON</sub>           |             | $V_I = 0$ ,            | f = 1 MHz,  | Outputs open,           | Switch ON  |  | 9    | 9.8  | pF   |
| r <sub>on</sub>           |             | $V_{DD} = 3 V$ ,       | $1.5 \text{ V} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{DD}},$ | $I_O = -40 \text{ mA}$  |            |  | 4    | 8    | Ω    |
| r <sub>on(flat)</sub> (3) |             | V <sub>DD</sub> = 3 V, | $V_I = 1.5 \text{ V} \text{ and } V_{DD},$                          | I <sub>O</sub> = -40 mA |            |  | 0.7  |      | Ω    |
| $\Delta r_{on}$ (4)       |             | $V_{DD} = 3 V$ ,       | $1.5 \text{ V} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{DD}},$ | $I_O = -40 \text{ mA}$  |            |  | 0.8  | 1.5  | Ω    |

- $V_{I},\,V_{O},\,I_{I},\,$  and  $I_{O}$  refer to I/O pins.  $V_{IN}$  refers to the control inputs. All typical values are at  $V_{DD}=3.3$  V (unless otherwise noted),  $T_{A}=25^{\circ}C.$   $r_{on(flat)}$  is the difference of  $r_{on}$  in a given channel at specified voltages.  $\Delta r_{on}$  is the difference of  $r_{on}$  from center (A4, A5) ports to any other port.

#### **ELECTRICAL CHARACTERISTICS**

for 10/100 Base-T Ethernet switching over recommended operating free-air temperature range,  $V_{DD}$  = 3.3 V  $\pm$  0.3 V

(unless otherwise noted)

| Р                     | ARAMETER    |                           | TEST CO  | MIN T                                       | YP <sup>(2)</sup> | MAX | UNIT |      |    |
|-----------------------|-------------|---------------------------|--|---|-------------------|-----|------|------|----|
| $V_{IK}$              | SEL, PD     | V <sub>DD</sub> = 3.6 V,  | I <sub>IN</sub> = -18 mA   |   |                   |     | -0.7 | -1.2 | V  |
| I <sub>IH</sub>       | SEL, PD     | $V_{DD} = 3.6 V,$         | $V_{IN} = V_{DD}$  |   |                   |     |      | ±2   | μΑ |
| I <sub>IL</sub>       | SEL, PD     | $V_{DD} = 3.6 V,$         | $V_{IN} = GND$   |   |                   |     |      | ±1   | μΑ |
| I <sub>OFF</sub>      | SEL, PD     | $V_{DD} = 0 V$ ,          | $V_{IN} = 0$ to 3.6 V  |   |                   |     |      | ±1   | μΑ |
| I <sub>CC</sub>       | •           | $V_{DD} = 3.6 \text{ V},$ | $I_{I/O}=0,$   | Switch ON or OFF                            |                   |     | 250  | 600  | μΑ |
| I <sub>CC_PD</sub>    |             | $V_{DD} = 3.6 V,$         | $V_{IN} = 3.6 V,$  | PD = High                                   |                   |     | 1    |      |    |
| C <sub>IN</sub>       | SEL, PD     | f = 1 MHz,                | $V_{IN} = 0$   |   |                   |     | 2.6  | 3.0  | pF |
| $C_{OFF}$             | B or C port | $V_I = 0$ ,               | f = 10 MHz,  | Outputs open,                               | Switch OFF        |     | 3    | 4    | pF |
| C <sub>ON</sub>       |             | $V_I = 0$ ,               | f = 10 MHz,  | Outputs open,                               | Switch ON         |     | 9    | 9.8  | pF |
| r <sub>on</sub>       |             | $V_{DD} = 3 V$ ,          | $1.25 \text{ V} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{DD}},$ | $I_O = -10$ mA to $-30$ mA                  |                   |     | 4    | 6    | Ω  |
| r <sub>on(flat)</sub> | (3)         | $V_{DD} = 3 V$ ,          | $V_I = 1.25 \text{ V} \text{ and } V_{DD},$                          | $I_{O} = -10 \text{ mA to } -30 \text{ mA}$ |                   |     | 0.5  |      | Ω  |
| $\Delta r_{on}$ (4)   |             | $V_{DD} = 3 V$ ,          | $1.25 \text{ V} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{DD}},$ | $I_O = -10$ mA to $-30$ mA                  | ·                 |     | 0.8  | 1.5  | Ω  |

- $V_{l},\,V_{O},\,I_{l},\,$  and  $I_{O}$  refer to I/O pins.  $V_{lN}$  refers to the control inputs. All typical values are at  $V_{DD}=3.3$  V (unless otherwise noted),  $T_{A}=25^{\circ}C.$   $r_{on(flat)}$  is the difference of  $r_{on}$  from center (A4, A5) ports to any other port.

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#### SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range,  $V_{DD}$  = 3.3 V ± 0.3 V,  $R_L$  = 200  $\Omega$ ,  $C_L$  = 10 pF

(unless otherwise noted) (see Figure 5 and Figure 6)

| PARAMETER  | FROM<br>(INPUT) | TO<br>(OUTPUT) | MIN | TYP <sup>(1)</sup> | MAX | UNIT |
|--|-----------------|----------------|-----|--------------------|-----|------|
| t <sub>pd</sub> <sup>(2)</sup>                   | A or B/C        | B/C or A       |     | 0.3                |     | ns   |
| t <sub>PZH</sub> , t <sub>PZL</sub>              | SEL             | A or B/C       | 0.5 |                    | 15  | ns   |
| $t_{PHZ}$ , $t_{PLZ}$                            | SEL             | A or B/C       | 0.9 |                    | 9   | ns   |
| t <sub>sk(o)</sub> (3)                           | A or B/C        | B/C or A       |     | 50                 | 100 | ps   |
| $t_{sk(p)}$ <sup>(4)</sup>                       | A or B/C        | B/C or A       |     | 50                 | 100 | ps   |
| t <sub>ON</sub> /t <sub>OFF</sub> <sup>(5)</sup> | PD              | A or B/C       |     |                    | 250 | ns   |

- All typical values are at  $V_{DD}$  = 3.3 V (unless otherwise noted),  $T_A$  = 25°C. The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance when driven by an ideal voltage source (zero output impedance). Output skew between center port ( $A_4$  to  $A_5$ ) to any other port
- Skew between opposite transitions of the same output in a given device |t<sub>PHL</sub> t<sub>PLH</sub>|
- Device enable/disable time from PD

#### DYNAMIC CHARACTERISTICS

over recommended operating free-air temperature range,  $V_{DD}$  = 3.3 V ± 0.3 V (unless otherwise noted)

| PARAMETER         | İ                   | TEST CONDITIONS T                         |              |     |    |  |  |  |  |
|-------------------|---------------------|---|--------------|-----|----|--|--|--|--|
| X <sub>TALK</sub> | $R_L = 50 \Omega$ , | = 50 $\Omega$ , f = 250 MHz, See Figure 8 |              |     |    |  |  |  |  |
| O <sub>IRR</sub>  | $R_L = 50 \Omega$ , | f = 250 MHz,                              | See Figure 9 | -37 | dB |  |  |  |  |
| BW                |                     | See Figure 7                              |              |     |    |  |  |  |  |

(1) All typical values are at  $V_{CC}$  = 3.3 V (unless otherwise noted),  $T_A$  = 25°C.



#### **OPERATING CHARACTERISTICS**

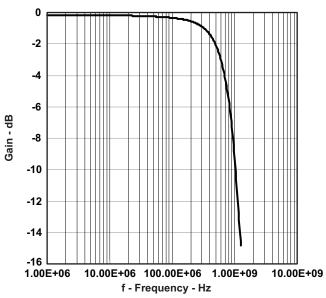


Figure 1. Gain vs Frequency

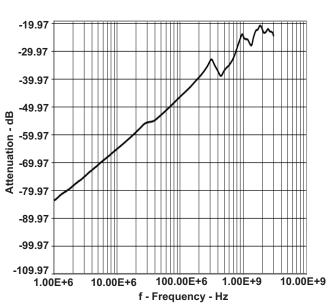


Figure 3. Crosstalk vs Frequency

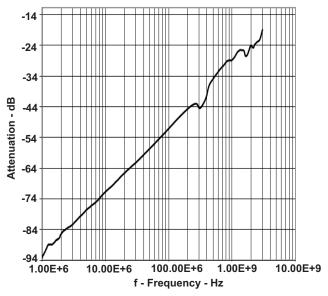


Figure 2. OFF Isolation vs Frequency

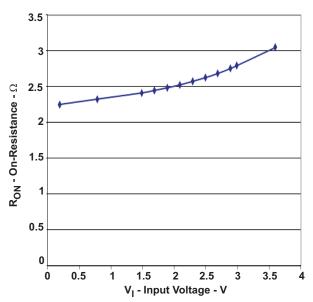
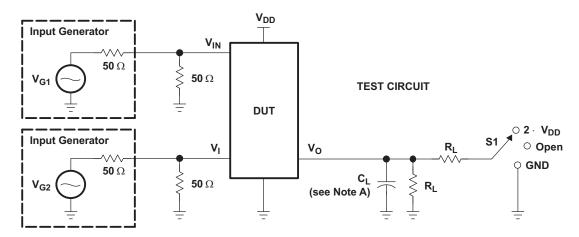


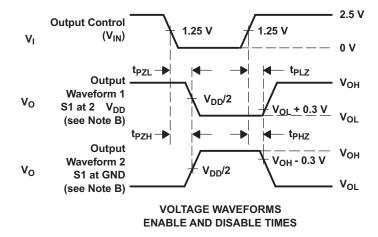
Figure 4.  $r_{on}$  ( $\Omega$ ) vs  $V_{com}$  (V)



## PARAMETER MEASUREMENT INFORMATION (Enable and Disable Times)



| TEST                               | V <sub>DD</sub> | S1                  | $R_{L}$ | V <sub>in</sub> | CL    | $oldsymbol{V}_{\Delta}$ |
|------------------------------------|-----------------|---------------------|---------|-----------------|-------|-------------------------|
| t <sub>PLZ</sub> /t <sub>PZL</sub> | 3.3 V           | 2 · V <sub>DD</sub> | 200 Ω   | GND             | 10 pF | 0.3 V                   |
| t <sub>PHZ</sub> /t <sub>PZH</sub> | 3.3 V           | GND                 | 200 Ω   | V <sub>DD</sub> | 10 pF | 0.3 V                   |



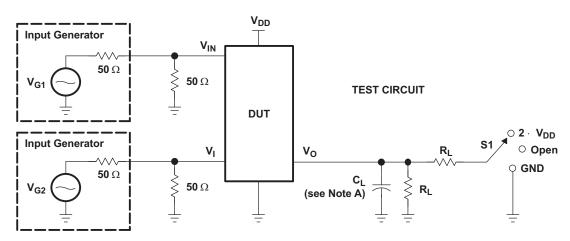
NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR $\leq$  10 MHz,  $Z_0 = 50 \,\Omega$ ,  $t_r \leq 2.5 \,\text{ns}$ .
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .

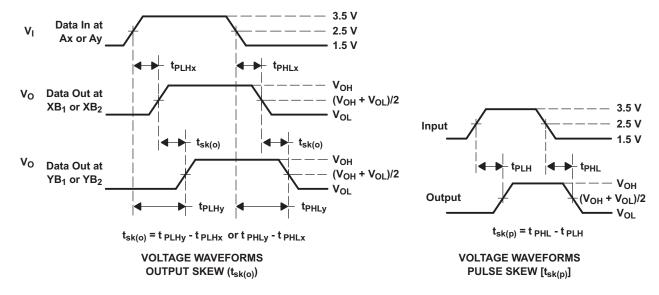
Figure 5. Test Circuit and Voltage Waveforms



## PARAMETER MEASUREMENT INFORMATION (Skew)



| TEST               | V <sub>DD</sub> S1 |      | R <sub>L</sub> | V <sub>in</sub>        | CL    |
|--------------------|--------------------|------|----------------|------------------------|-------|
| t <sub>sk(o)</sub> | 3.3 V $\pm$ 0.3 V  | Open | 200 Ω          | V <sub>DD</sub> or GND | 10 pF |
| t <sub>sk(p)</sub> | 3.3 V ± 0.3 V      | Open | 200 Ω          | V <sub>DD</sub> or GND | 10 pF |



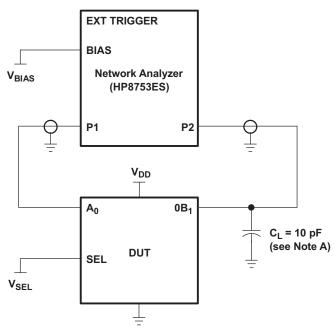
NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR $\leq$  10 MHz,  $Z_0$  = 50  $\Omega$ ,  $t_r \leq$  2.5 ns,  $t_f \leq$  2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 6. Test Circuit and Voltage Waveforms



#### PARAMETER MEASUREMENT INFORMATION



A.  $C_L$  includes probe and jig capacitance.

Figure 7. Test Circuit for Frequency Response (BW)

Frequency response is measured at the output of the ON channel. For example, when  $V_{SEL}=0$  and  $A_0$  is the input, the output is measured at  $0B_1$ . All unused analog I/O ports are left open.

#### **HP8753ES Setup**

Average = 4

RBW = 3 kHz

 $V_{BIAS} = 0.35 \text{ V}$ 

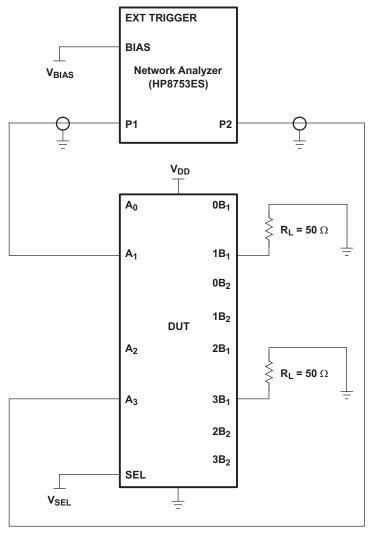
ST = 2 s

P1 = 0 dBM

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#### PARAMETER MEASUREMENT INFORMATION (continued)



- A. C<sub>L</sub> includes probe and jig capacitance.
- B. A  $50-\Omega$  termination resistor is needed to match the loading of the network analyzer.

Figure 8. Test Circuit for Crosstalk (X<sub>TALK</sub>)

Crosstalk is measured at the output of the nonadjacent ON channel. For example, when  $V_{SEL} = 0$  and  $A_1$  is the input, the output is measured at  $A_3$ . All unused analog input (A) ports are connected to GND, and output (B) ports are left open.

#### **HP8753ES Setup**

Average = 4

RBW = 3 kHz

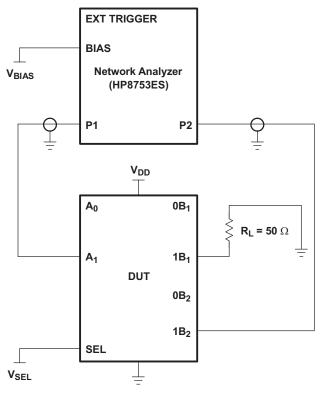
 $V_{BIAS} = 0.35 V$ 

ST = 2 s

P1 = 0 dBM



## PARAMETER MEASUREMENT INFORMATION (continued)



- A. C<sub>L</sub> includes probe and jig capacitance.
- B. A 50-Ω termination resistor is needed to match the loading of the network analyzer.

Figure 9. Test Circuit for OFF Isolation (OIRR)

OFF isolation is measured at the output of the OFF channel. For example, when  $V_{SEL}$  = GND and  $A_1$  is the input, the output is measured at  $1B_2$ . All unused analog input (A) ports are connected to ground, and output (B) ports are left open.

#### **HP8753ES Setup**

Average = 4

RBW = 3 kHz

 $V_{BIAS} = 0.35 V$ 

ST = 2 s

P1 = 0 dBM

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5-Nov-2012

#### **PACKAGING INFORMATION**

| Orderable Device | Status | Package Type | _       | Pins | Package Qty | Eco Plan                   | Lead/Ball Finish | MSL Peak Temp      | Samples          |
|------------------|--------|--------------|---------|------|-------------|----------------------------|------------------|--------------------|------------------|
|                  | (1)    |              | Drawing |      |             | (2)                        |                  | (3)                | (Requires Login) |
| TS3L501ERUAR     | ACTIVE | WQFN         | RUA     | 42   | 3000        | Green (RoHS<br>& no Sb/Br) | Call TI          | Level-1-260C-UNLIM |                  |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

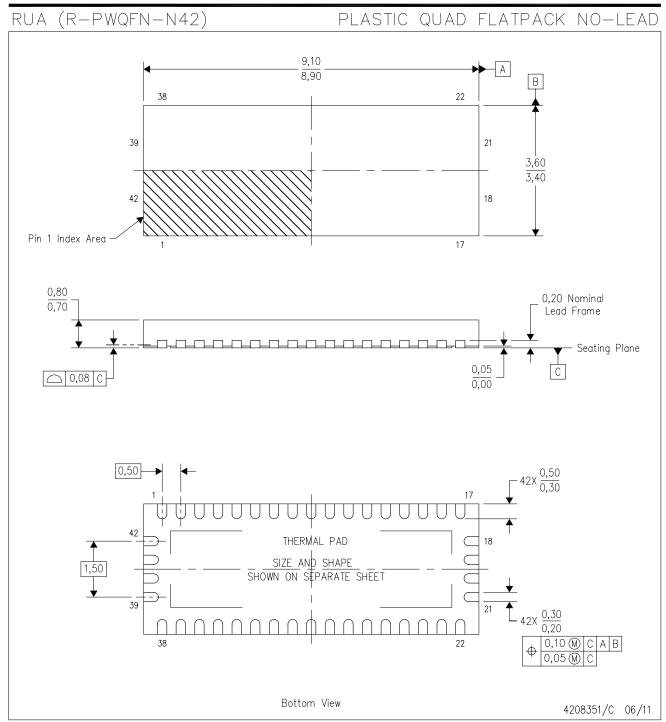
**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.



## RUA (R-PWQFN-N42)

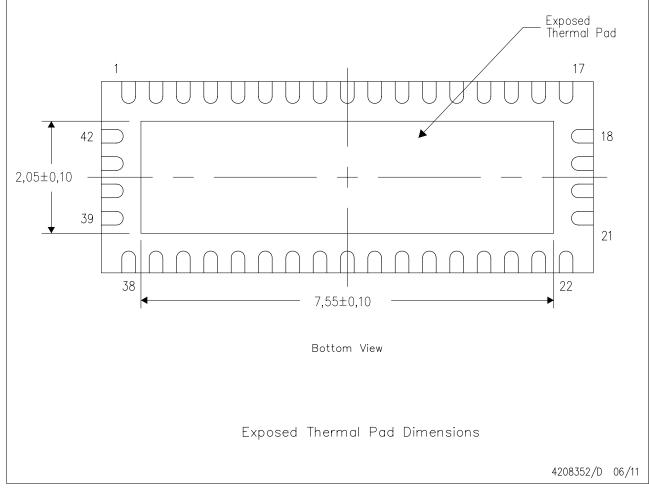
PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

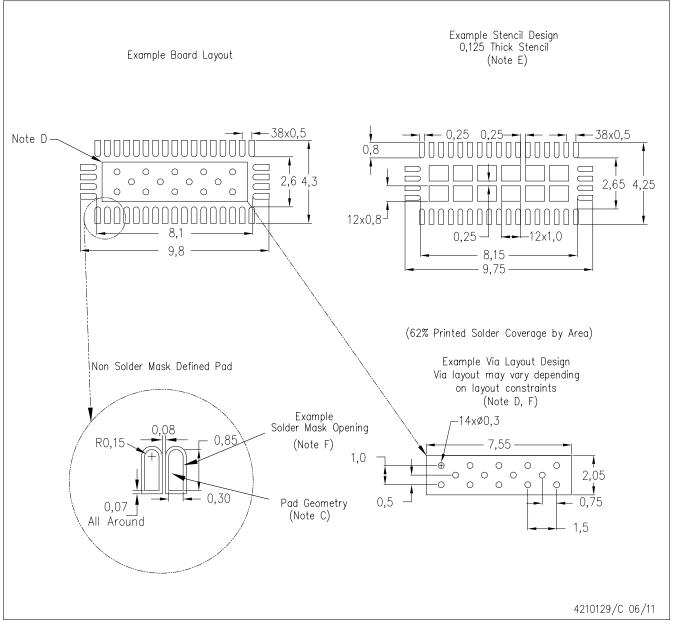


NOTE: All linear dimensions are in millimeters



## RUA (R-PWQFN-N42)

## PLASTIC QUAD FLATPACK NO-LEAD



#### NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="https://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.



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